

PRODUCT SUMMARY

	$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
Q2	30V	$0.85m\Omega$	85A
Q1	30V	$5m\Omega$	53A

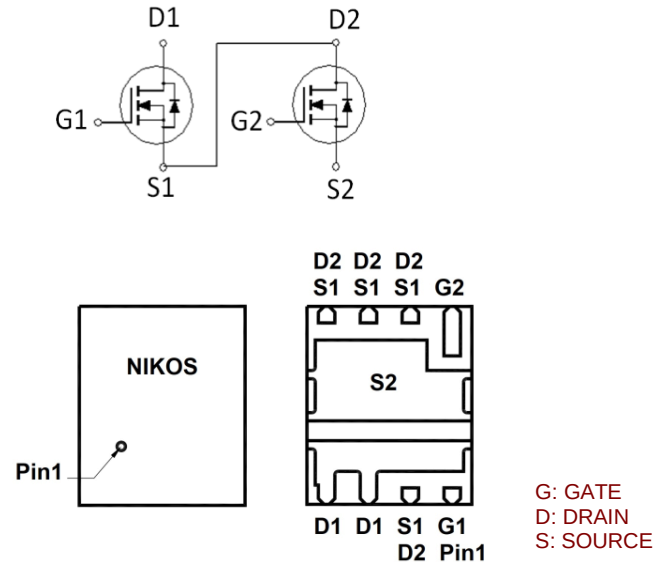


Features

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.
- 100% UIS and Rg Tested.

Applications

- Computing DC to DC converters.
- Communications DC to DC converters.
- General Purpose Point of load.



ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	Q2	Q1	UNITS
Drain-Source Voltage		V_{DS}	30	30	V
Gate-Source Voltage		V_{GS}	± 20	± 20	V
Continuous Drain Current ³	$T_C = 25\text{ }^{\circ}\text{C}$	I_D	85	53	A
	$T_C = 100\text{ }^{\circ}\text{C}$		85	34	
Pulsed Drain Current ¹		I_{DM}	358	120	
Continuous Drain Current	$T_A = 25\text{ }^{\circ}\text{C}$	I_D	59	19	A
	$T_A = 70\text{ }^{\circ}\text{C}$		47	15	
Avalanche Current		I_{AS}	127	59	
Avalanche Energy	$L = 0.01\text{mH}$	E_{AS}	81	17	mJ
Power Dissipation	$T_C = 25\text{ }^{\circ}\text{C}$	P_D	63	25	W
	$T_C = 100\text{ }^{\circ}\text{C}$		25	10	
Power Dissipation ⁴	$T_A = 25\text{ }^{\circ}\text{C}$	P_D	5.2	3	W
	$T_A = 70\text{ }^{\circ}\text{C}$		3.3	2	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150		$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL		TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10s$	$R_{\theta JA}$	Q2		24	°C / W
			Q1		41	
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$	Q2		43	
			Q1		69	
Junction-to-Case	Steady-State	$R_{\theta JC}$	Q2		2	
			Q1		5	

¹Pulse width limited by maximum junction temperature $T_{J(MAX)}=150^{\circ}C$.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$. The value in any given application depends on the user's specific board design.

³The maximum current rating is Package limited.

⁴The Power dissipation is based on $R_{\theta JA} t \leq 10s$ value.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS				UNIT	
			MIN	TYP	MAX			
STATIC								
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	Q2	30			V	
			Q1	30				
Drain-Source Breakdown Voltage (transient)	$V_{(BR)DSSt}$	$T_{case} = 25\text{ }^{\circ}C, t_{transient} < 100ns$	Q2	35				
			Q1	35				
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	Q2	1.2	1.7	2.2		
			Q1	1.2	1.7	2.2		
Gate-Body Leakage	I_{GSS}	$V_{DS}=0V, V_{GS}=\pm 20V$	Q2			± 100		nA
		$V_{DS}=0V, V_{GS}=\pm 20V$	Q1			± 100		
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=30V, V_{GS}=0V$	Q2			1	μA	
			Q1			1		
		$V_{DS}=30V, V_{GS}=0V, T_J=55\text{ }^{\circ}C$	Q2			10		
			Q1			10		
Drain-Source On-State Resistance ⁵	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=16A$	Q2		1.1	1.2	mΩ	
		$V_{GS}=4.5V, I_D=13A$	Q1		5.4	8		
		$V_{GS}=10V, I_D=20A$	Q2		0.75	0.85		
		$V_{GS}=10V, I_D=13A$	Q1		3.5	5		
Forward Transconductance ⁵	g_{fs}	$V_{DS}=5V, I_D=20A$	Q2		93		S	
		$V_{DS}=5V, I_D=13A$	Q1		56			

DYNAMIC									
Input Capacitance	C _{iss}		V _{GS} =0V, V _{DS} =15V, f=1MHz	Q2		4169		pF	
				Q1		1043			
Output Capacitance	C _{oss}			Q2		1319			
				Q1		248			
Reverse Transfer Capacitance	C _{rss}			Q2		98			
				Q1		81			
Gate Resistance	R _g			Q2		1.3		Ω	
				Q1		1.9			
Total Gate Charge ⁶	Q _g	V _{GS} =10V		Q2 V _{DS} =15V, V _{GS} =10V, I _D =20A Q1 V _{DS} =15V, V _{GS} =10V, I _D =13A	Q2		62	87	nC
			Q1			20	28		
		V _{GS} =4.5V	Q2			29	41		
			Q1			10	14		
Gate-Source Charge ⁶	Q _{gs}		Q2			11			
			Q1			2.5			
Gate-Drain Charge ⁶	Q _{gd}		Q2			6.2			
			Q1			4.5			
Turn-On Delay Time ⁶	t _{d(on)}	Q2 V _{DS} =15V, I _D ≅20A, V _{GS} =10V, R _{GEN} =6 Ω Q1 V _{DS} =15V, I _D ≅13A, V _{GS} =10V, R _{GEN} =6 Ω	Q2			15		nS	
			Q1		8				
Rise Time ⁶	t _r		Q2		70				
			Q1		57				
Turn-Off Delay Time ⁶	t _{d(off)}		Q2		78				
			Q1		28				
Fall Time ⁶	t _f		Q2		82				
			Q1		67				
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _J = 25 °C)									
Continuous Current	I _S			Q2			63	A	
				Q1			21		
Forward Voltage ⁵	V _{SD}	I _F =20A, V _{GS} =0V		Q2			1	V	
		I _F =13A, V _{GS} =0V		Q1			1.2		
Reverse Recovery Time	t _{rr}	Q2 I _F =20A, dI _F /d =400A / μS Q1 I _F =13A, dI _F /dt=400A / μS		Q2		41		nS	
				Q1		12			
Reverse Recovery Charge	Q _{rr}			Q2		81		nC	
				Q1		9.2			

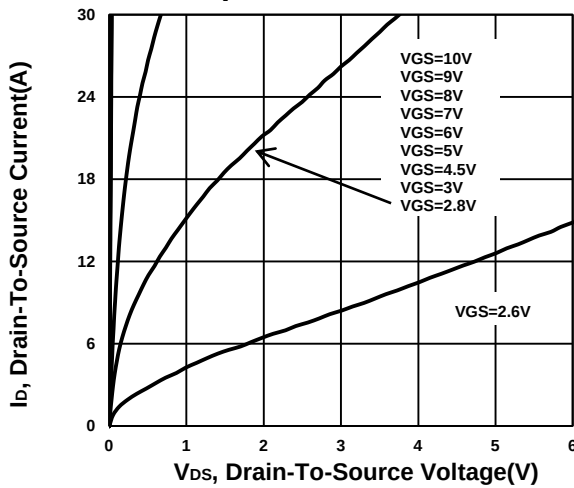
⁵Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.

⁶Independent of operating temperature.

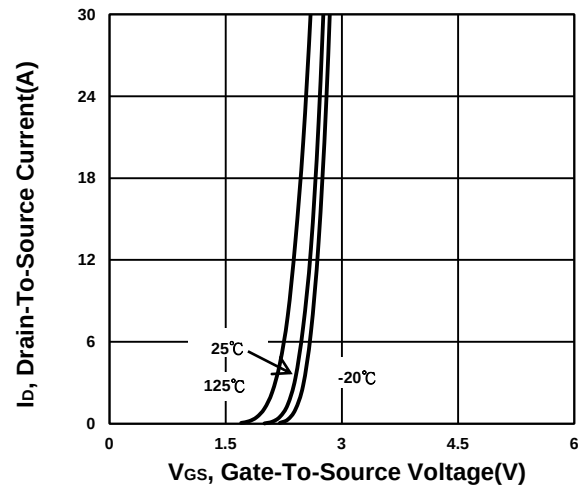
TYPICAL PERFORMANCE CHARACTERISTICS

Q2

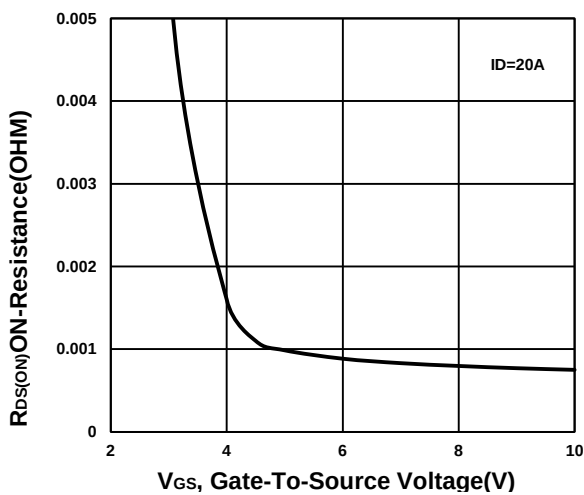
Output Characteristics



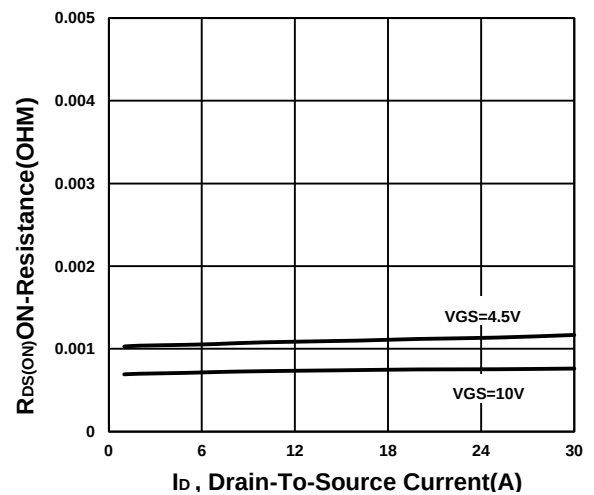
Transfer Characteristics



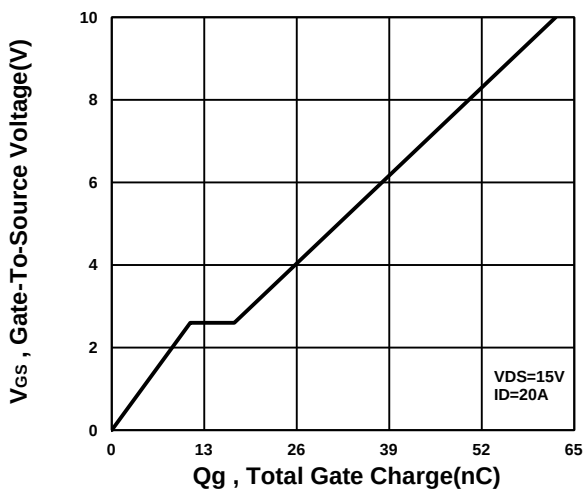
On-Resistance VS Gate-To-Source Voltage



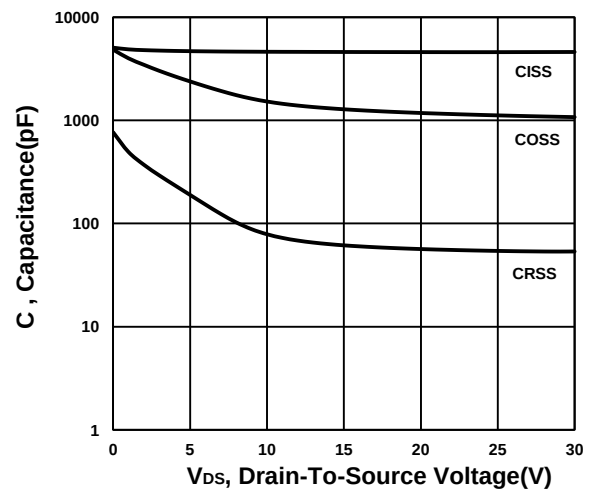
On-Resistance VS Drain Current



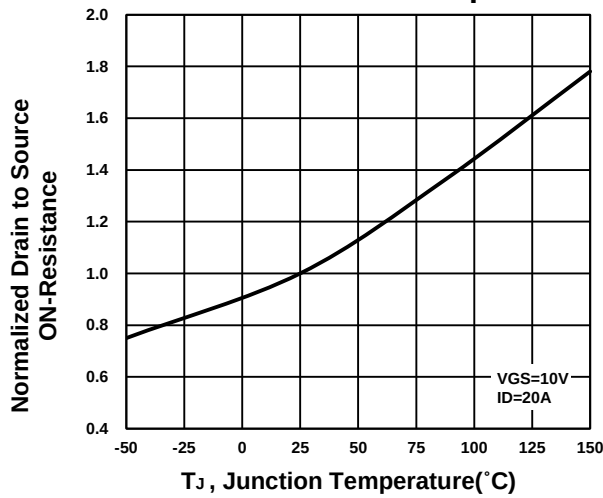
Gate charge Characteristics



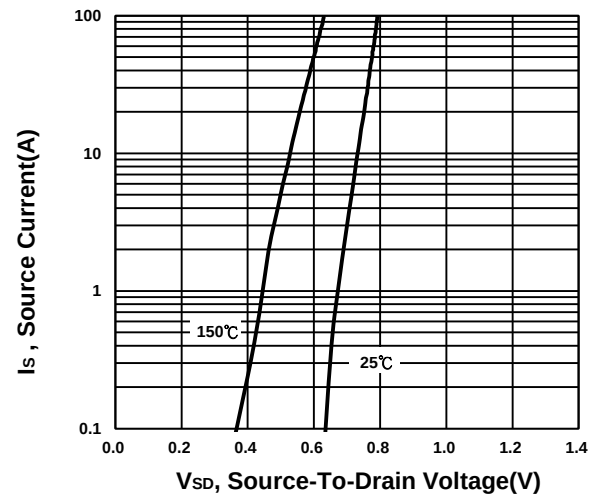
Capacitance Characteristic



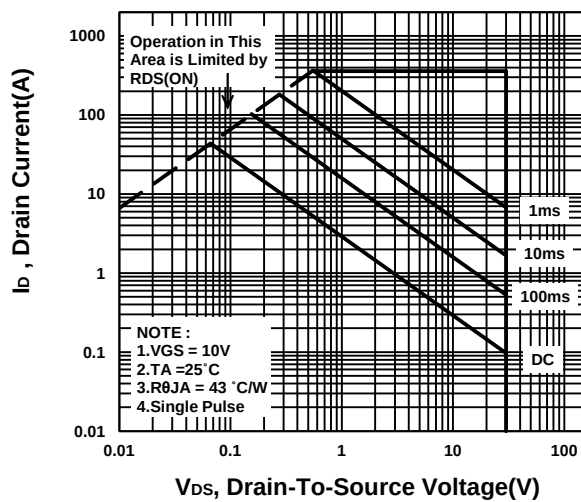
On-Resistance VS Temperature



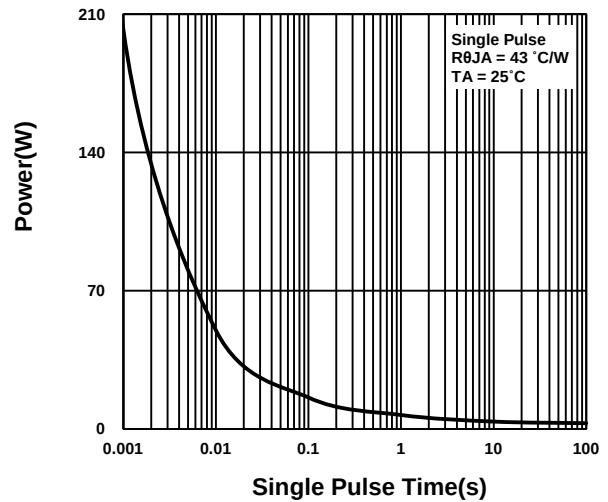
Source-Drain Diode Forward Voltage



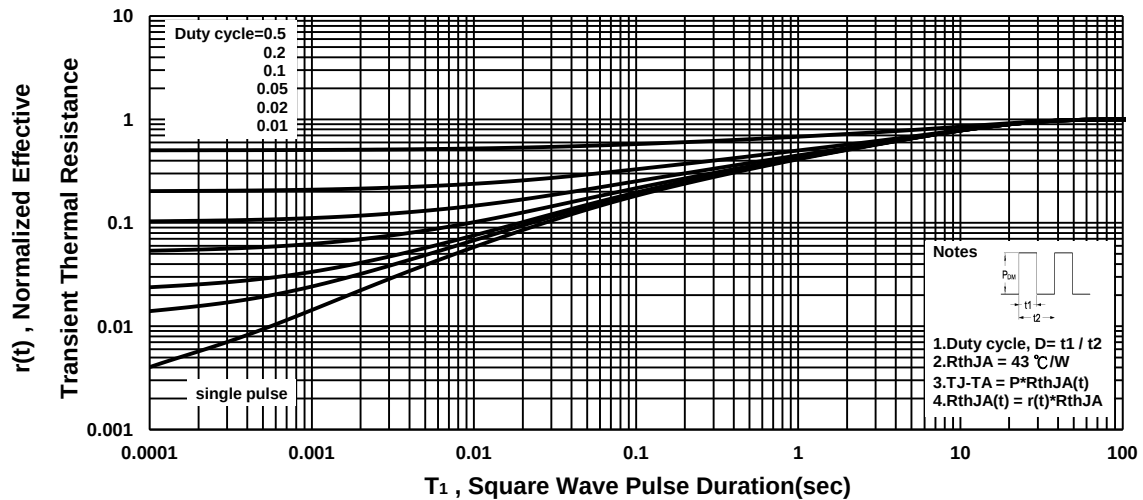
Safe Operating Area



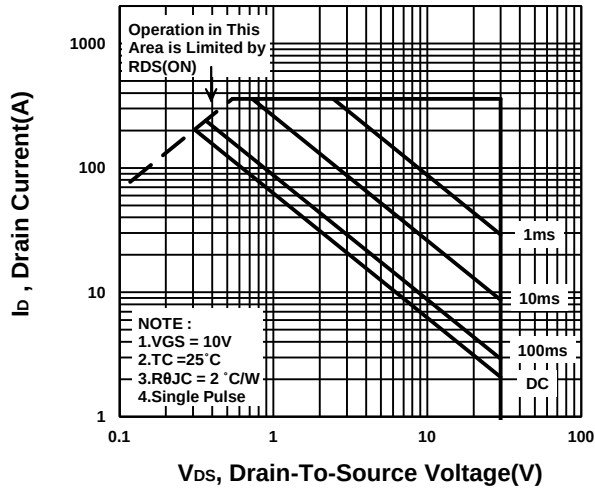
Single Pulse Maximum Power Dissipation



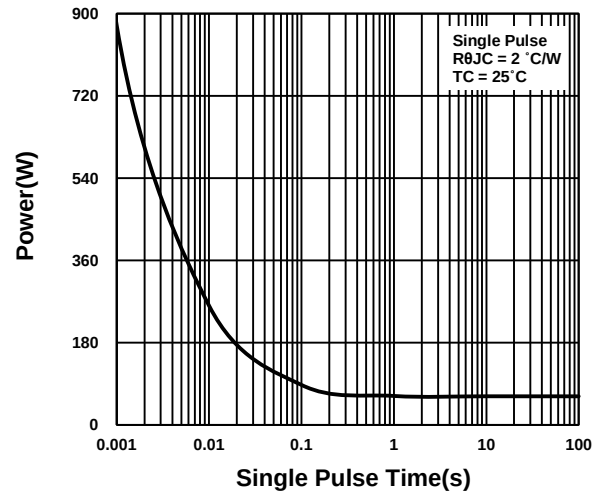
Transient Thermal Response Curve



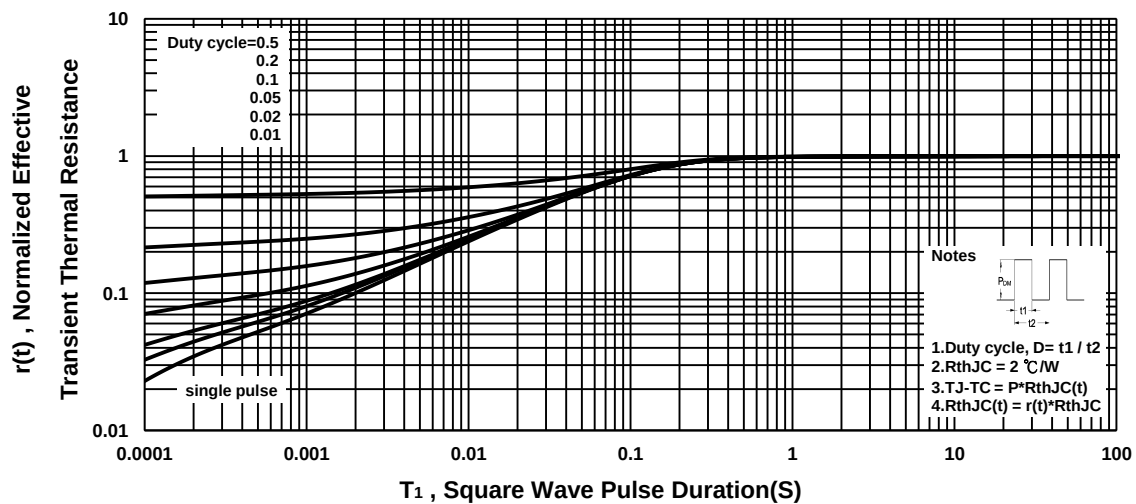
Safe Operating Area



Single Pulse Maximum Power Dissipation

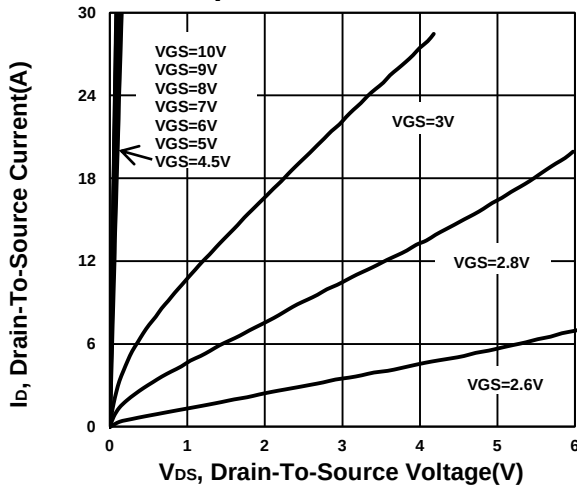


Transient Thermal Response Curve

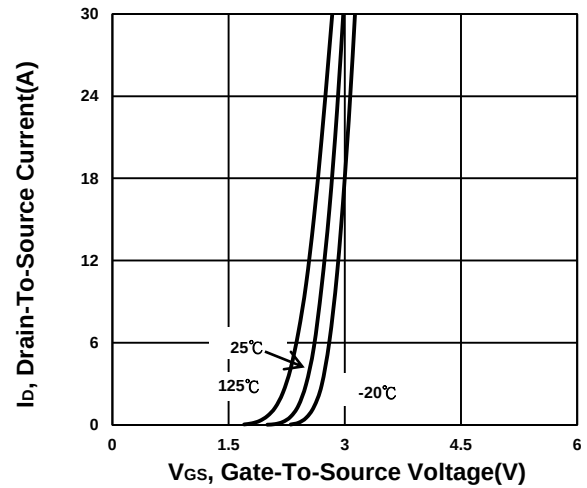


Q1

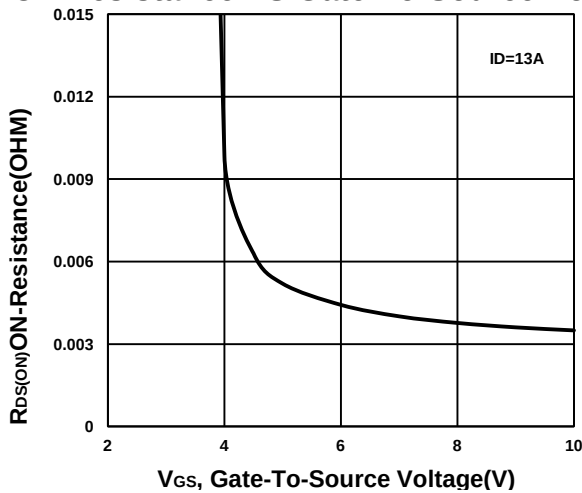
Output Characteristics



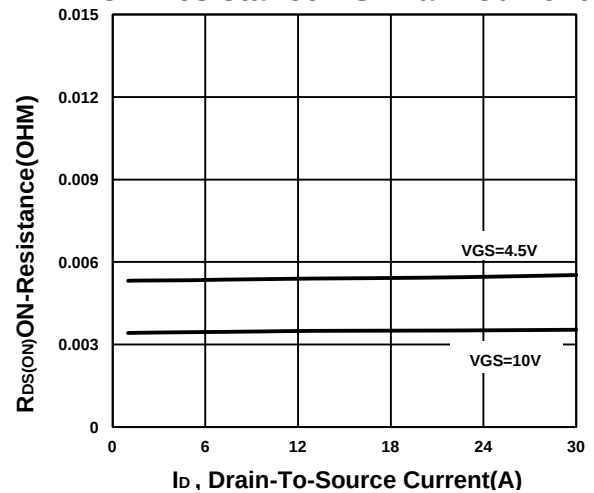
Transfer Characteristics



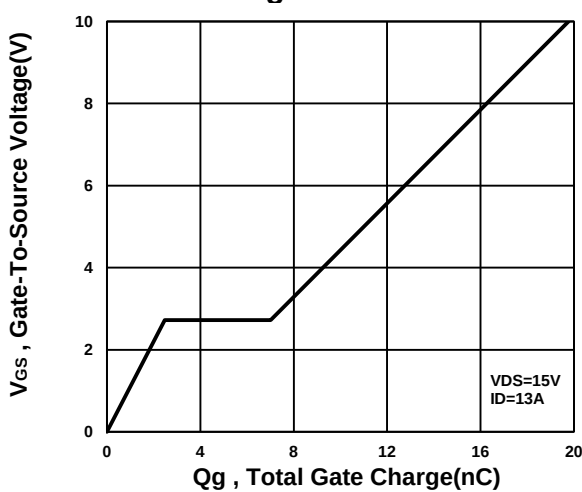
On-Resistance VS Gate-To-Source Voltage



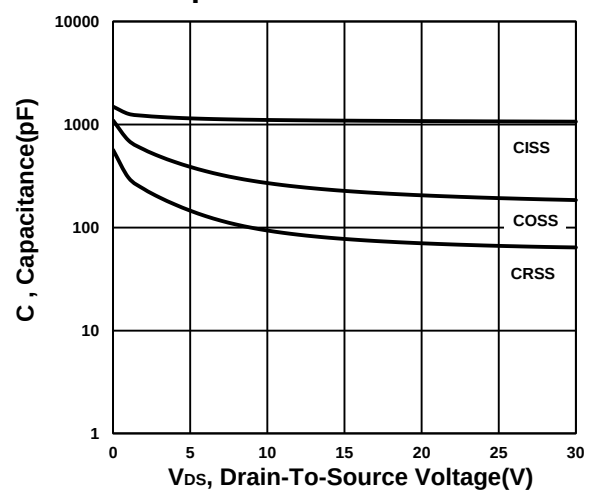
On-Resistance VS Drain Current



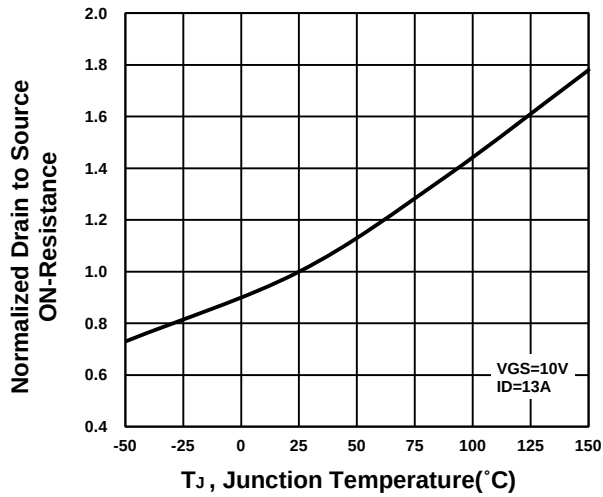
Gate charge Characteristics



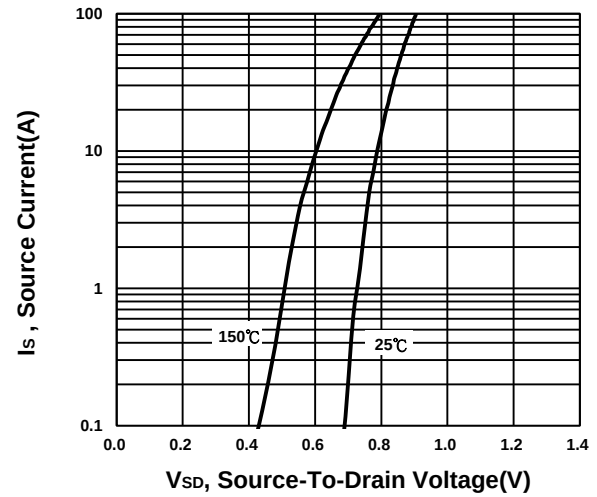
Capacitance Characteristic



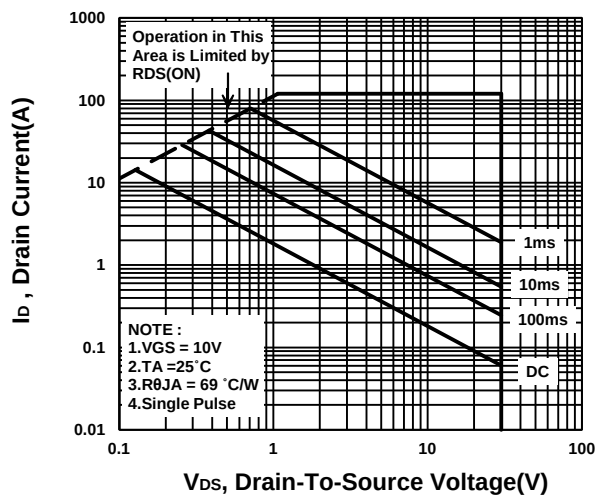
On-Resistance VS Temperature



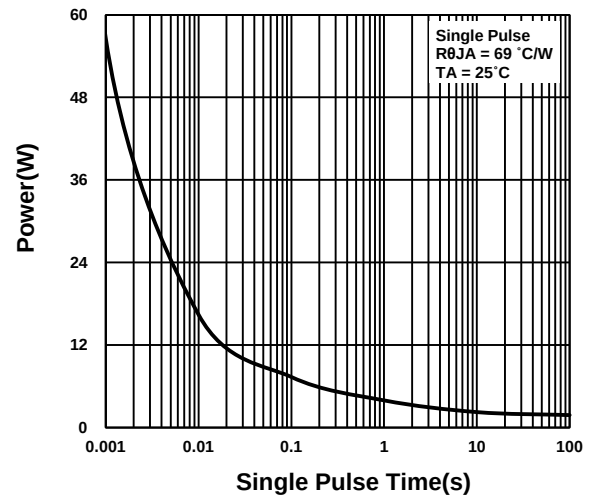
Source-Drain Diode Forward Voltage



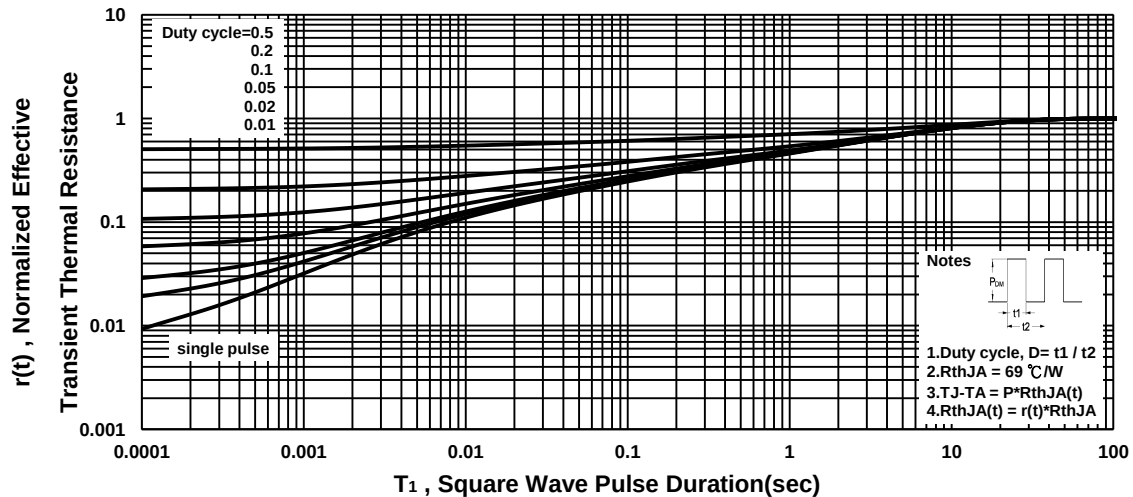
Safe Operating Area



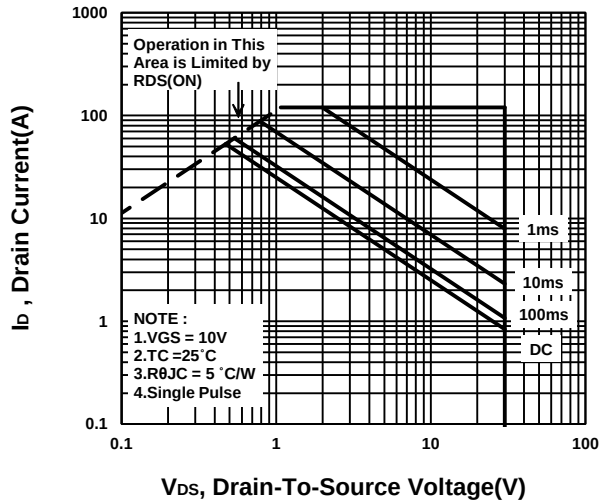
Single Pulse Maximum Power Dissipation



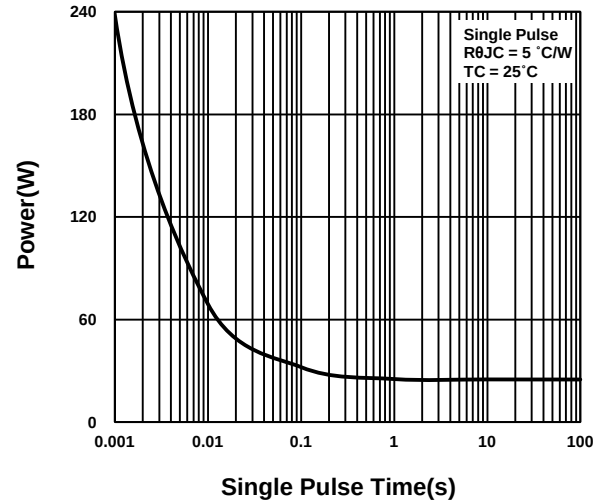
Transient Thermal Response Curve



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

